A8305

Single LNB Supply and Control Voltage Regulator

Discontinued Product

These parts are no longer in production The device should not be purchased for new design applications. Samples are no longer available.

Date of status change: July 1, 2024

Recommended Substitutions:

For existing customer transition, and for new customers or new applications, contact Allegro Sales.

NOTE: For detailed information on purchasing options, contact your local Allegro field applications engineer or sales representative.

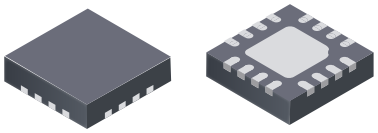
Single LNB Supply and Control Voltage Regulator

FEATURES AND BENEFITS

- Integrated boost MOSFET, current sensing, and compensation
- Stable with low-profile ceramic boost capacitors
- New 15.67 V output setting to accommodate designs in the Japan market
- Adjustable LNB output current limit from 250 to 950 mA*
  - Covers wide array of application requirements
  - Minimizes component sizing to fit each application
  - For startup, reconfiguration, and continuous output
- Boost peak current limit scales with LNB current limit setting
- 8 programmable LNB output voltage (DAC) levels
- LNB overcurrent limiter with shutdown timer
- Static LNB current limit reliably starts a wide range of loads
- Tracking boost converter minimizes power dissipation
- LNB transition times configurable by external capacitor
- Push-pull LNB output stage maintains 13→18 V and 18→13 V transition times, even with highly capacitive loads

Continued on the next page…

PACKAGE: 16-contact QFN (suffix ES)



3 mm × 3 mm × 0.75 mm

DESCRIPTION

Intended for analog and digital satellite receivers, this single low noise block converter regulator (LNBR) is a monolithic linear and switching voltage regulator, specifically designed to provide the power and the interface signals to an LNB down converter via coaxial cable. The A8305 requires few external components, with the boost switch and compensation circuitry integrated inside of the device. A high switching frequency is chosen to minimize the size of the passive filtering components, further assisting in cost reduction. The high levels of component integration ensure extremely low noise and ripple figures.

The A8305 has been designed for high efficiency, utilizing the Allegro™ advanced BCD process. The integrated boost switch has been optimized to minimize both switching and static losses. To further enhance efficiency, the voltage drop across the tracking regulator has been minimized.

For DiSEqC™ communications, a tone control pin is provided to gate the internally-generated 22 kHz tone on-and-off.

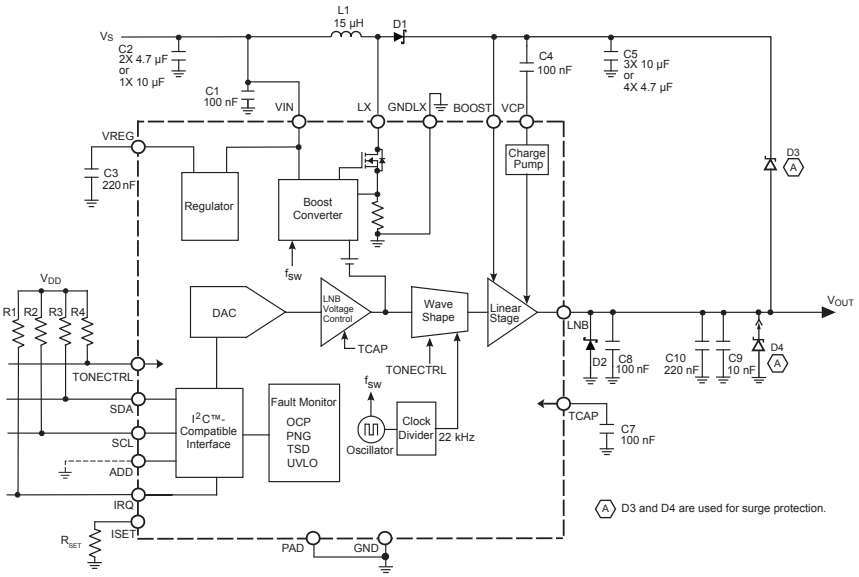
A comprehensive set of fault registers are provided, which comply with all the common standards, including: overcurrent, thermal shutdown, undervoltage, and power not good.

Furthermore, design methodology and structure ensure the highest level of robustness against transients and component failures. The device uses a 2-wire bidirectional serial interface, compatible with the I²C™ standard, that operates up to 400 kHz.

The A8305 is supplied in a lead (Pb) free package.

Functional Block Diagram

See table 6 for bill of materials



FEATURES AND BENEFITS (continued)

- Built-in 22 kHz tone oscillator facilitates DiSEqC™ tone encoding, even at no-load
- Tone generation does not require additional external components
- Diagnostic features: PNG
- Extensive protection features: UVLO, OCP, TSD, CPOK
- 2-wire I²C-compatible interface

*maximum value depends on PCB thermal design

SELECTION GUIDE

Part Number	Packing [1]	Description
A8305SESTR-T [2]	7 in. reel, 1500 pieces/reel 12 mm carrier tape	ES package, MLP/QFN surface mount 3 mm × 3 mm × 0.75 mm nominal height

[1] Contact Allegro for additional packing options.
[2] Leadframe plating 100% matte tin.

ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Conditions	Rating	Unit
Load Supply Voltage, VIN pin	V_{IN}		30	V
Output Current [3]	I_{OUT}		Internally Limited	A
Output Voltage, BOOST pin			–0.3 to 43	V
Output Voltage, LNB pin		Surge [4]	–1.0 to 43	V
Output Voltage, LX pin			–0.3 to 30	V
Output Voltage, VCP pin			–0.3 to 48	V
Logic Input Voltage			–0.3 to 5.5	V
Logic Output Voltage			–0.3 to 5.5	V
Operating Ambient Temperature	T_A	Range S	–20 to 85	°C
Junction Temperature	T_J(max)		150	°C
Storage Temperature	T_{stg}		–55 to 150	°C

[1] Output current rating may be limited by duty cycle, ambient temperature, and heat sinking. Under any set of conditions, do not exceed the specified current ratings, or a junction temperature, T_J, of 150°C.
[2] Use Allegro recommended application circuit.

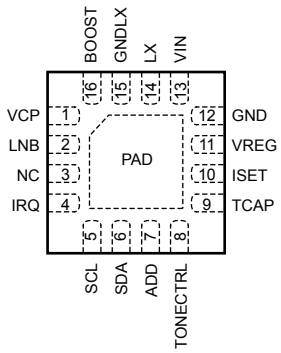
PACKAGE THERMAL CHARACTERISTICS [5]

Package	$R_{\theta JA}$ (°C/W)	PCB
ES	47	4-layer

[5] Additional information is available on the Allegro website.

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

Pinout Diagram



Terminal List Table

Name	Number	Function
ADD	7	Address select
BOOST	16	Tracking supply voltage to linear regulator
GND	12	Signal ground
GNDLX	15	Boost switch ground
IRQ	4	Interrupt request
ISET	10	Output current limit set via external resistor
LNB	2	Output voltage to satellite dish
LX	14	Inductor drive point
NC	3	No connection
PAD	Pad	Exposed pad; connect to the ground plane, for thermal dissipation
SCL	5	I^2C™-compatible clock input
SDA	6	I^2C™-compatible data input/output
TCAP	9	Capacitor for setting the rise and fall time of the LNB output
TONECTRL	8	Gates the 22 kHz tone on-and-off
VCP	1	Gate supply voltage
VIN	13	Supply input voltage
VREG	11	Analog supply

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

ELECTRICAL CHARACTERISTICS [1] **at T_A = 25°C, V_{IN} = 10 to 16 V, • as noted** [2]**, unless noted otherwise**

Characteristics	Symbol	Test Conditions		Min.	Typ.	Max.	Unit
GENERAL							
Output Voltage Accuracy	V_{OUT}	V_{IN} = 12 V, I_{OUT} = 50 mA, see table 3 for DAC settings	•	–2	–	2	%
Load Regulation	$\Delta V_{OUT(Load)}$	V_{IN} = 12 V, V_{OUT} = 13.667 V, ΔI_{OUT} = 50 to 450 mA	•	–	38	76	mV
		V_{IN} = 12 V, V_{OUT} = 19.000 V, ΔI_{OUT} = 50 to 450 mA	•	–	45	90	mV
Line Regulation	$\Delta V_{OUT(Line)}$	V_{IN} = 10 to 16 V, V_{OUT} = 13.667 V, I_{OUT} = 50 mA	•	–10	0	10	mV
		V_{IN} = 10 to 16 V, V_{OUT} = 19.000 V, I_{OUT} = 50 mA	•	–10	0	10	mV
Supply Current	$I_{IN(OFF)}$	ENB = 0, V_{IN} = 12 V		–	4	–	mA
	$I_{IN(ON)}$	ENB = 1, V_{IN} = 12 V, V_{OUT} = 19 V, I_{LOAD} = 0 mA, TONECTRL = 0		–	11	–	mA
		ENB = 1, V_{IN} = 12 V, V_{OUT} = 19 V, I_{LOAD} = 0 mA, TONECTRL = 1		–	17	–	mA
Boost Switch On Resistance	$R_{DS(on)}$ BOOST	I_{SW} = 450 mA		–	300	–	mΩ
Switching Frequency	f_{SW}			320	352	384	kHz
Linear Regulator Voltage Drop	ΔV_{REG}	$V_{BOOST} – V_{LNB}$, no tone signal, I_{LOAD} = 425 mA		600	800	1000	mV
TCAP Pin Current	I_{TCAP}	TCAP capacitor (C12) charging		–13	–10	–7	µA
		TCAP capacitor (C12) discharging		7	10	13	µA
Output Voltage Rise Time [3]	$t_{r(VLNB)}$	For V_{LNB} 13.667 to 19.667 V; C_{12} = 100 nF, I_{LOAD} = 500 mA		–	10	–	ms
Output Voltage Pull-Down Time [3]	$t_{f(VLNB)}$	For V_{LNB} 19.667 to 13.667 V; C_{LOAD} = 100 µF, I_{LOAD} = 0 mA		–	25	–	ms
LNB Sink Current [3]	I_{RLNB}	ENB = 0, V_{LNB} = 21 V, Boost capacitor fully charged		–	2	4	mA
		ENB = 1, $VSEL_{2,1,0}$ = 001 (13.667 V), V_{LNB} = 21 V, TONECTRL = 0 or 1		–	9	15	mA
		ENB = 1, $VSEL_{2,1,0}$ = 101 (19.000 V), V_{LNB} = 21 V, TONECTRL = 0 or 1		–	9	15	mA
		ENB = 1, $VSEL_{2,1,0}$ = 110 (19.667 V), 18.5 V < V_{LNB} <21 V, TONECTRL = 0		–	30	40	mA
LNB Off Current	$I_{LNB(Off)}$	V_{IN} = 16 V		–	–	10	µA

Continued on the next page…

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

ELECTRICAL CHARACTERISTICS [1] **(continued) at T_A = 25°C, V_{IN} = 10 to 16 V, • as noted** [2]**, unless noted otherwise**

Characteristics	Symbol	Test Conditions		Min.	Typ.	Max.	Unit
GENERAL (continued)							
Ripple and Noise on LNB Output [4]	$V_{rip,n(pp)}$	20 MHz BWL; reference circuit shown in Application Information section; contact Allegro for additional information on application circuit board design		–	15	–	mV_{PP}
VREG Voltage	V_{VREG}	V_{IN} = 10 V		4.97	5.25	5.53	V
ISET Voltage	V_{ISET}	V_{IN} = 10 V		3.4	3.5	3.6	V
TCAP Voltage	V_{TCAP}	V_{IN} = 10 V, V_{OUT} = 13.667 V		–	2.28	–	V
		V_{IN} = 10 V, V_{OUT} = 19.000 V		–	3.17	–	V
PROTECTION CIRCUITRY							
Output Overcurrent Limit [5]	$I_{OUT(MAX)}$	R_{SET} = 100 kΩ	•	250	300	350	mA
		R_{SET} = 60.4 kΩ	•	450	500	550	mA
Overcurrent Disable Time	t_{DIS}			–	45	–	ms
VIN Undervoltage Lockout Threshold	V_{UVLO}	V_{IN} falling		8.05	8.35	8.65	V
VIN Turn On Threshold	$V_{IN(th)}$	V_{IN} rising		8.40	8.70	9.00	V
Undervoltage Hysteresis	$V_{UVLOHYS}$			–	350	–	mV
Boost MOSFET Current Limit	$I_{BOOST(MAX)}$	R_{SET} = 100 kΩ		–	1680	–	mA
		R_{SET} = 60.4 kΩ		–	2600	–	mA
Thermal Shutdown Threshold [3]	T_J			–	165	–	°C
Thermal Shutdown Hysteresis [3]	ΔT_J			–	20	–	°C
Power Not Good (Low)	PNG_{LOSET}	With respect to V_{LNB} setting; V_{LNB} low, PNG set to 1		88	91	94	%
	$PNG_{LORESET}$	With respect to V_{LNB} setting; V_{LNB} low, PNG reset to 0		92	95	98	%
Power Not Good (Low) Hysteresis	PNG_{LOHYS}	With respect to V_{LNB} setting		–	4	–	%
Power Not Good (High)	PNG_{HISET}	With respect to V_{LNB} setting; V_{LNB} high, PNG set to 1		106	109	112	%
	$PNG_{HIRESET}$	With respect to V_{LNB} setting; V_{LNB} high, PNG reset to 0		102	105	108	%
Power Not Good (High) Hysteresis	PNG_{HIHYS}	With respect to V_{LNB} setting		–	4	–	%
TONE							
Amplitude	$V_{TONE(PP)}$	I_{LNB} = 0 to 425 mA, C_{LNB} = 750 nF	•	400	650	900	mV_{PP}
Frequency	f_{TONE}	I_{LNB} = 0 to 425 mA, C_{LNB} = 750 nF	•	20	22	24	kHz
Duty Cycle	DC_{TONE}	I_{LNB} = 0 to 425 mA, C_{LNB} = 750 nF		40	50	60	%
Rise Time	$t_{R(TONE)}$	I_{LNB} = 0 to 425 mA, C_{LNB} = 750 nF		5	10	15	µs
Fall Time	$t_{F(TONE)}$	I_{LNB} = 0 to 425 mA, C_{LNB} = 750 nF		5	10	15	µs

Continued on the next page…

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

ELECTRICAL CHARACTERISTICS [1] (continued) at T_A = 25°C, V_{IN} = 10 to 16 V, • as noted [2], unless noted otherwise

Characteristics	Symbol	Test Conditions		Min.	Typ.	Max.	Unit
TONE CONTROL (TONECTRL)							
Logic Input	V_H			2.0	–	–	V
	V_L			–	–	0.8	V
Input Leakage				–1	–	1	µA
I²C™-COMPATIBLE INTERFACE							
Logic Input (SDA,SCL) Low Level	$V_{SCL(L)}$			–	–	0.8	V
Logic Input (SDA,SCL) High Level	$V_{SCL(H)}$			2.0	–	–	V
Logic Input Hysteresis	$V_{I2CIHYS}$			–	150	–	mV
Logic Input Current	I_{I2CI}	V_{I2CI} = 0 to 5 V		–1	<±1.0	1	µA
Logic Output Voltage SDA and IRQ	$V_{OUT(L)}$	I_{LOAD} = 3 mA		–	–	0.4	V
Logic Output Leakage SDA and IRQ	V_{LKG}	V_{OUT} = 0 to 5 V		–	–	10	µA
SCL Clock Frequency	f_{CLK}			–	–	400	kHz
I²C™ ADDRESS SETTING							
ADD Voltage for Address 0001,000	Address1			0	–	0.7	V
ADD Voltage for Address 0001,001	Address2			1.3	–	1.7	V
ADD Voltage for Address 0001,010	Address3			2.3	–	2.7	V
ADD Voltage for Address 0001,011	Address4			3.3	–	5.0	V

[1] Operation at 16 V may be limited by power loss in the linear regulator.
[2] Indicates specifications guaranteed from $0 \le T_J \le 125^{\circ}C_{MIN}$.
[3] Guaranteed by worst case process simulations and system characterization. Not production tested.
[4] LNB output ripple and noise are dependent on component selection and PCB layout. Not production tested.
[5] Current from the LNB output may be limited by the choice of Boost components.

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

FUNCTIONAL DESCRIPTION

Protection

The A8305 has a wide range of protection features and fault diagnostics which are detailed in the Status Register section.

Boost Converter/Linear Regulator

The A8305 solution contains a tracking current-mode boost converter and linear regulator. The boost converter tracks the requested LNB voltage to within 800 mV, to minimize power dissipation. Under conditions where the input voltage, V_{BOOST}, is greater than the output voltage, V_{LNB}, the linear regulator must drop the differential voltage. When operating in these conditions, care must be taken to ensure that the safe operating temperature range of the A8305 is not exceeded.

The boost converter operates at 352 kHz typical: 16 times the internal 22 kHz tone frequency. All the loop compensation, current sensing, and slope compensation functions are provided internally.

The A8305 has internal pulse-by-pulse current limiting on the boost converter and DC current limiting on the LNB output to protect the IC against short circuits. When the LNB output is shorted, the LNB output current is limited, and if the overcurrent condition lasts for more than 45 ms, the LNB output will be disabled. If this occurs, the A8305 output must be reenabled for normal operation. The system should provide sufficient time between successive restarts to limit internal power dissipation; 1 s to 2 s is recommended

At extremely light load or no load, if the BOOST voltage tries to exceed the BOOST target voltage, the boost converter operates with minimum on time. BOOST settling voltage depends on supply voltage, boost inductance, minimum on time, switching frequency, output power and power loss in boost inductor, capacitor and A8305. If the BOOST voltage settles below pulse skipping threshold (23.7 V), the boost converter continues to operate with minimum on time. If BOOST voltage tries to exceed 23.7 V, pulse skipping occurs, and pulse skipping stops when the BOOST voltage drops to 23.4 V.

In the case that two or more set top box LNB outputs are connected together by the customer (e.g., with a splitter), it is possible that one output could be programmed at a higher voltage than the other. This would cause a voltage on one output that is higher than its programmed voltage (e.g., 19 V on the output of a 13 V programmed voltage). The output with the highest voltage will effectively turn off the other outputs. As soon as this voltage is reduced below the value of the other outputs, the A8305 output will auto-recover to their programmed levels.

Charge Pump. Generates a supply voltage above the internal tracking regulator output to drive the linear regulator control.

LNB and BOOST Current Limits. The LNB output current limit, $I_{OUT(MAX)}$ can be set by connecting a resistor (RSET) from the ISET pin to GND as shown in the functional block diagram. The LNB current limit can be set from 300 to 500 mA, corresponding to an R_{SET} value of 100 to 60.4 kΩ, respectively. If the LNB current limit is exceeded for more than the Overcurrent Disable Time (t_{DIS}) then the A8305 will be shut down and the OCP bit set, as shown in figure 1. The LNB output current limit can be set as high as 650 mA (R_{SET} = 46 kΩ) but care should be taken not to exceed the thermal limit of the package or thermal shutdown (TSD) will occur. The typical LNB output current limit can be set according to the following equation:

$$I_{OUT(MAX)} = 29{,}925 / R_{SET} \ ,$$

where $I_{OUT(MAX)}$ is in mA and R_{SET} is in kΩ. If the voltage at the ISET pin is 0 V (that is, shorted to GND), $I_{OUT(MAX)}$ will be clamped to a moderately high value (approximately 1.5 A). Care should be taken to ensure that ISET is not inadvertently grounded. If no resistor is connected to the ISET pin (that is, if ISET is open-circuit), $I_{OUT(MAX)}$ will be set to approximately 0 A and the A8305 will not support any load (OCP will occur prematurely).

The BOOST pulse-by-pulse current limit, $I_{BOOST(MAX)}$, is automatically scaled along with the LNB output current limit. The typical BOOST current limit is set according to the following equation:

$$I_{BOOST(MAX)} = 4.7 \times I_{OUT(MAX)} + 270 \text{ mA} \ ,$$

where both $I_{BOOST(MAX)}$ and $I_{OUT(MAX)}$ are in mA.

Automatically scaling the BOOST current limit allows the designer to choose the lowest possible saturation current of the boost inductor, reducing its physical size and PCB area, thus minimizing cost.

Slew Rate Control. During either start-up, or when the output voltage at the LNB pin is transitioning, the output voltage rise and fall times can be set by the value of the capacitor connected from the TCAP pin to GND. Note that during start-up, the BOOST pin is pre-charged to the input voltage minus a diode voltage drop. As a result, the slew rate control for the BOOST

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

pin occurs from this voltage.

The value of C7 can be calculated using the following formula:

$$C_7 = (I_{TCAP} \times 6) / SR \ ,$$

where SR is the required slew rate of the LNB output voltage, in V/s, and I_{TCAP} is the TCAP pin current specified in the Electrical Characteristics table. The recommended value for C_7, 100 nF, should provide satisfactory operation for most applications.

The minimum value of C_7 is 10 nF. There is no theoretical maximum value of C_7 however too large a value will probably cause the voltage transition specification to be exceeded. Tone generation is unaffected by the value of C_7.

Pull-Down Rate Control. In applications that have to operate at very light loads and that require large load capacitances (in the order of tens to hundreds of microfarads), the output linear stage provides approximately 45 mA of pull-down capability. This ensures that the LNB output voltage is ramped from 18 to 13 V in a reasonable amount of time. When the tone is on (TONECTRL = 1), the output linear stage must increase its pull-down capability to approximately 100 mA. This ensures that the tone signal meets all specifications, even with no load on the on the LNB output.

ODT (Overcurrent Disable Time)

If the LNB output current exceeds the set output current, for more than 45 ms, then the LNB output will be disabled and the OCP bit will be set. See figure 1.

Short Circuit Handling

If the LNB output is shorted to ground, the LNB output current will be clamped to $I_{OUT(MAX)}$. If the short circuit condition lasts for more than 45 ms, the A8305 will be disabled and the OCP bit will be set.

Auto-Restart

After a short circuit condition occurs, the host controller should periodically reenable the A8305 to check if the short circuit has been removed. Consecutive startup attempts should allow 1 s to 2 s of delay between restarts.

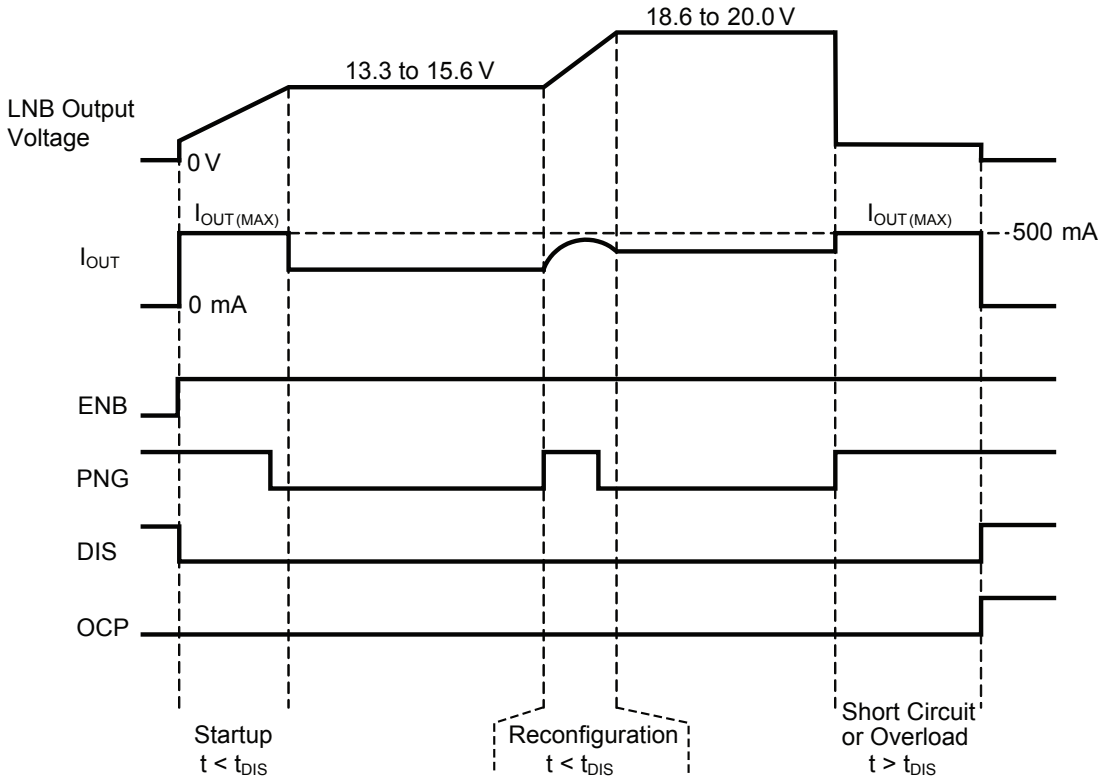


Figure 1. Startup, Reconfiguration, and Short Circuit operation using R_{SET} = 60.4 kΩ, and a capacitive load

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

In-Rush Current

At start-up or during an LNB reconfiguration event, a transient surge current above the normal DC operating level can be provided by the A8305. This current increase can be as high as the set output current, for as long as required, up to a maximum of 45 ms.

Tone Generation

A 22 kHz tone is generated internally, and can be controlled on and off via the TONECTRL pin as shown in figure 2. Note this tone can be generated under no-load conditions, and does not require the use of an external DiSEqC filter.

Component Selection

BOOST INDUCTOR

The A8305 is designed to operate with a boost inductor value of 15 µH +30%/–40% with a DCR less than 75 mΩ. The error amplifier loop compensation, current sense gain, and PWM slope compensation were chosen for this value of inductor. The boost inductor must be able to support the peak currents required to maintain the maximum LNB output current without saturating. Figure 3 can be used to determine the peak current in the inductor given the LNB load current. The "typical" curve uses V_{IN} = 12 V, V_{OUT} = 19 V, L = 15 µH, and f = 352 kHz, while the "maximum" curve assumes V_{IN} = 9 V, V_{OUT} = 20 V, L = 12 µH, and f = 282 kHz.

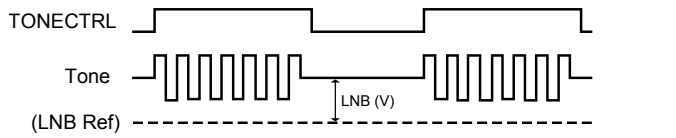


Figure 2. Internal tone, gated by TONECTRL pin

BOOST CAPACITORS

The A8305 is designed to operate with three or four, high-quality ceramic capacitors on the boost node. Allegro recommends capacitors that are rated at least 35 V, ±10%, X7R, 1210 size. Physically smaller capacitors, like 0603 and 0805, with lower temperature ratings, like X5R and Z5U, should be avoided. Figure 4 can be used to determine the necessary rms current rating of the boost capacitor given the LNB load current. The "typical" curve uses V_{IN} = 12 V, V_{OUT} = 19 V, L = 15 µH, and f = 352 kHz while the "maximum" curve assumes V_{IN} = 9 V, V_{OUT} = 20 V, L = 12 µH, and f = 282 kHz.

The nominal boost capacitance should total 18.8 to 30 µF. Allegro recommends either four 4.7 µF or three 10 µF capacitors, with the characteristics shown in table 1. If tolerance, temperature, and DC bias effects are considered, the capacitance must total at least 13 µF. The DC bias effect is very significant on ceramic capacitors with lower voltage ratings, smaller packages, or wider temperature characteristics. For example, a 10 µF, 25 V, 1206, X5R capacitor can lose 85% of its value at 20 VDC bias. If the total boost capacitance becomes less than 12 µF, the converter will have reduced gain and phase margins. If the total boost capacitance becomes less than 7.5 µF, then the converter will very likely be unstable.

Two possible ceramic based capacitor solutions have been presented. Other capacitor combinations are certainly possible, such as a very low ESR electrolytic capacitor in parallel with several

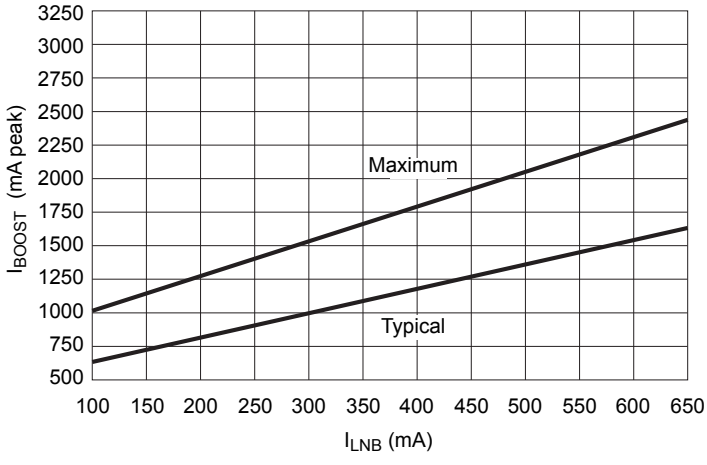


Figure 3. Boost inductor peak current versus I_{LNB} for the A8305

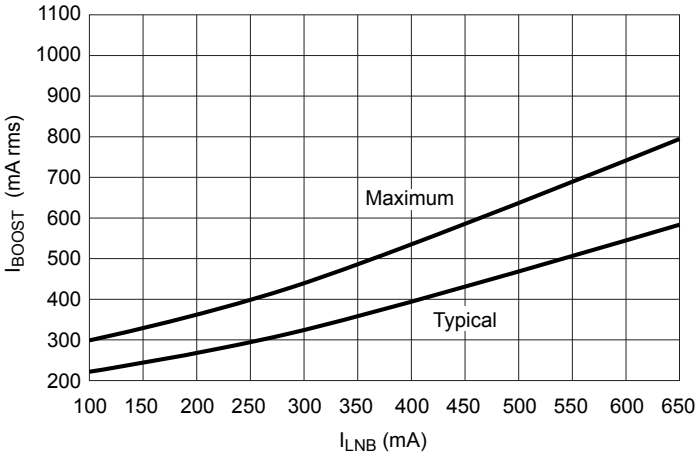


Figure 4. Boost capacitor rms current versus I_{LNB} for the A8305

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

microfarads of ceramic capacitance. However, there are two critical requirements that must be satisfied: 1) the zero formed by the electrolytic capacitor and its ESR should be at least 1 decade higher than the 0 dB crossover of the boost loop (typically around 25 kHz), and 2) the ceramic capacitors must eliminate the high frequency switching spikes/edges in the boost voltage, or the LNB output noise will be too high.

BOOST FILTERING AND LNB NOISE

The LNB output noise depends on the amount of high-frequency noise at the BOOST pin. To minimize the high-frequency noise at the BOOST pin, the ceramic capacitors should be placed as close as possible to the BOOST pin.

SURGE COMPONENTS

The circuit shown on page 1 of this datasheet includes D3 and D4 for surge protection. Component recommendations for D3 and D4 are given in the bill-of-materials at the end of this datasheet. This configuration and these components have successfully passed surge tests up to ±1000 V/500 A, with a 1.2/50 µs − 8/20 µs combination wave. Every application will have its own surge requirements and the surge solution can be changed. However, Allegro strongly recommends incorporating a form of surge protection to prevent any pin of the A8305 from exceeding its Absolute Maximum voltage ratings shown in this datasheet.

Table 1. Recommended Boost Capacitor Characteristics

Quantity of Capacitors	Value (µF)	Tolerance (%)	Rating (V)	Temperature Coefficient of Capacitance	Size	Total Capacitance at –10% and 20 VDC Bias (µF)
4	4.7	±10	50	X7R	1210	14.0
3	10	±10	35	X7R	1210	18.6

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

I²C™-Compatible Interface

The I²C™ interface is used to access the internal Control and Status registers of the A8305. This is a serial interface that uses two lines, serial clock (SCL) and serial data (SDA), connected to a positive supply voltage via a current source or a pull-up resistor. Data is exchanged between a microcontroller (master) and the A8305 (slave). The master always generates the SCL signal. Either the master or the slave can generate the SDA signal. The SDA and SCL lines from the A8305 are open-drain signals so multiple devices may be connected to the I²C™ bus. When the bus is free, both the SDA and the SCL lines are high.

SDA and SCL Signals. SDA can only be changed while SCL is low. SDA must be stable while SCL is high. However, an exception is made when the I²C™ Start or Stop condition is encountered. See the I²C™ Communication section for further details.

Acknowledge (AK) Bit. The Acknowledge (AK) bit indicates a "good transmission" and can be used two ways. First, if the slave has successfully received eight bits of either an address or control data, it will pull the SDA line low (AK = 0) for the ninth SCL pulse to signal "good transmission" to the master. Second, if the master has successfully received eight bits of status data from the A8305, it will pull the SDA line low for the ninth SCL pulse to signal "good transmission" to the slave. The receiver (either the master or the slave) should set the AK bit high (AK = 1 or NAK) for the ninth SCL pulse if eight bits of data are not received successfully.

AK Bit During a Write Sequence. When the master sends control data (writes) to the A8305 there are three instances where AK bits are toggled by the A8305. First, the A8305 uses the AK bit to indicate reception of a valid seven-bit chip address plus a read/write bit (R/W = 0 for write). Second, the A8305 uses the AK bit to indicate reception of a valid eight-bit Control register address. Third, the A8305 uses the AK bit to indicate reception of eight bits of control data. This protocol is shown in figure 5(A).

AK Bit During a Read Sequence. When the master reads status data from the A8305 there are four instances where AK bits are sent–three sent by the A8305 and one sent by the master. First, the A8305 uses the AK bit to indicate reception of a valid seven-bit chip address plus a read/write bit (R/W = 0 for write). Second, the A8305 uses the AK bit to indicate reception of a valid eight-bit status register address. Third, the A8305 uses the AK bit to indicate reception of a valid seven-bit chip address plus a read/write bit (R/W = 1 for read). Finally, the master uses the AK bit to indicate receiving eight bits of status data from the A8305. This protocol is shown in figure 5(B).

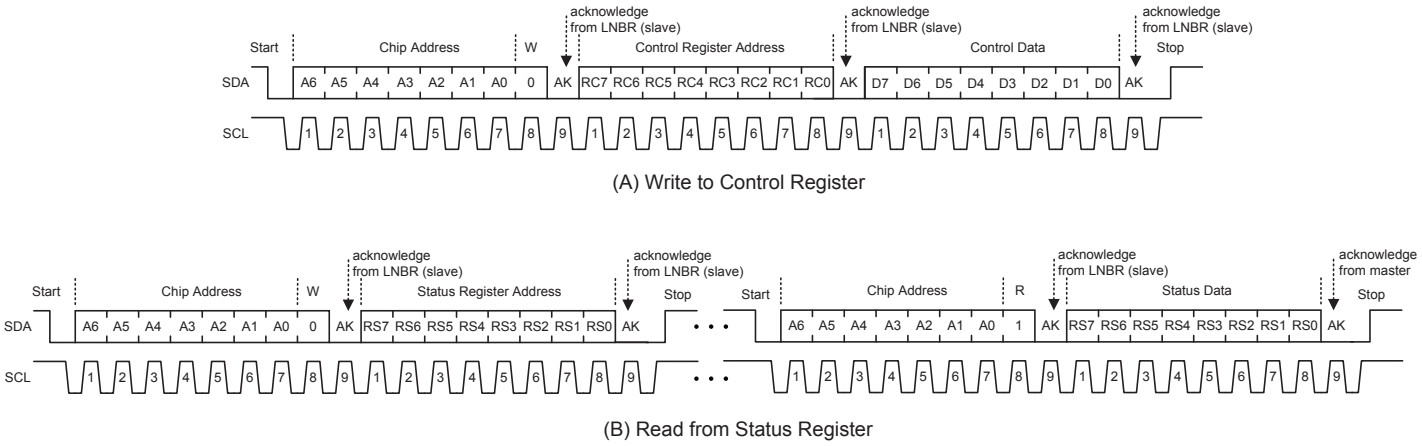


Figure 5. I²C™ Interface Read and Write Sequences. (A) for the I²C™ Write cycle and (B) for the I²C™ Read cycle

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

I²C™ Communications

I²C™ Start and Stop Conditions. The I²C™ Start condition is defined by a negative edge on the SDA line while SCL is high-Conversely, the Stop condition is defined by a positive edge on the SDA line while SCL is high. The Start and Stop conditions are shown in figure 5. It is possible for the Start or Stop condition to occur at any time during a data transfer. If either a Start or Stop condition is encountered during a data transfer, the A8305 will respond by resetting the data transfer sequence.

I²C™ Write Cycle Description. Writing to the A8305 Control register requires transmission of a total of 27 bits–three 8-bit bytes of data plus an Acknowledge bit after each byte. Writing to the A8305 Control register is shown in figure 5(A). Writing to the A8305 Control register requires a chip address with R/W = 0, a Control register address, and the control data, as follows:

- The Chip Address cycle consists of a total of nine bits–seven bits of chip address (A6 to A0) plus one read/write bit (R/W = 0) to indicate a write from the master followed by an Acknowledge bit (AK = 0 for reception of a valid chip address) from the slave. The chip address must be transmitted MSB (A6) first. The first five bits of the A8305 chip address (A6 to A2) are fixed as 00010. The remaining two bits (A1 and A0) are used to select one of four possible A8305 chip addresses. The DC voltage on the ADD pin programs the chip address. See the Electrical Characteristics table for the ADD pin voltages and the corresponding chip addresses.
- The Control Register Address cycle consists of a total of nine bits–eight bits of control register address (RC7 to RC0) from the master followed by an Acknowledge bit from the slave. The Control register address must be transmitted MSB (RC7) first. The A8305 only has one Control register so the Control register address is fixed as 00000000.
- The Control Data cycle consists of a total of nine bits–eight bits of control data (D7 to D0) from the master followed by an Acknowledge bit from the slave. The control data must be transmitted MSB first (D7). The Control register bits are identified in the Control Registers section of this datasheet.

I²C™ Read Cycle Description. Reading from the A8305 Status register requires transmission of a total of 36 bits–four 8-bit bytes of data plus an Acknowledge bit after each byte. Reading the A8305 Status register requires a chip address with R/W = 0, a Status register address, an I²C™ Stop condition, an I²C™ Start condition, a "repeated" chip address with R/W=1, and finally the status data from the A8305. Reading from the A8305 Status register is shown in figure 5(B).

- This 9-bit Chip Address cycle is identical to the Chip Address cycle previously described for the Write Control register sequence. It consists of A6 to A0, plus one read/write bit (R/W = 0) from the master, followed by an Acknowledge bit from the slave and finally an I²C™ Stop condition.
- The Status Register Address cycle consists of a total of nine bits–eight bits of Status register address (RS7 to RS0) from the master, followed by an Acknowledge bit from the slave. The Status register address must be transmitted MSB (RS7) first. The A8305 only has one Status register, so the Status register address is fixed at 00000000.
- The "Repeated" Chip Address cycle begins with an I²C™ Start condition followed by a 9-bit cycle identical to the Chip Address cycle previously described for the Write Control Register sequence. It consists of A6 to A0, plus one read/write bit (R/W = 1) from the master, followed by an Acknowledge bit from the slave.
- The Status Data cycle consists of a total of nine bits–eight bits of status data (RD7 to RD0) from the slave, followed by an Acknowledge bit from the master. The status data is transmitted MSB (RD7) first. The Status register bits are identified in the Status Register section of this data sheet.

Interrupt (IRQ) and Fault Clearing

The A8305 provides an interrupt request pin (IRQ), which is an open-drain, active low output. This output may be connected to a common IRQ line with a suitable external pull-up resistor and can be used with other I²C™ compatible devices to request attention from the master controller.

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

The IRQ output becomes active (logic low) when the A8305 recognizes a fault condition. The fault conditions that will force IRQ active include undervoltage lockout (UVLO), overcurrent protection (OCP), and thermal shutdown (TSD). The UVLO, OCP, and TSD faults are latched in the Status register and will not be unlatched until the A8305 Status register is successfully transmitted to the master controller (an AK bit must be received from the master). See the description in the Status Register section and figure 6 for further details.

The A8305 IRQ response to $V_{IN(UVLO)}$ is controlled by the I²C address setting. The A8305 has two methods to control the IRQ for UVLO fault:

- The first method uses the I²C address setting (Address 2, Address 3, or Address 4). In this method while V_{IN} is below 8.70 V (typ), the A8305 is disabled and the I²C port is inactive. After V_{IN} rises above 8.70 V (typ), the I²C port becomes active and the IRQ pin is pulled low. An I²C Read cycle is required to report and clear the UVLO fault and set the IRQ pin to a logic high before the A8305 can be enabled. If a brown-out occurs, such that V_{IN} drops below 8.35 V (typ), the A8305 will be disabled and the I²C port will become inactive (note that the IRQ pin will remain high during this time because the A8305 is disabled). After V_{IN} rises above 8.70 V (typ) the I²C port reactivates and the IRQ pin is pulled low to report that a brown-out had occurred. An I²C Read cycle is required to report and clear the UVLO fault before the A8305 can be re-enabled. A detailed timing diagram is shown in figure 7(A).
- The second method uses I²C address setting (Address 1). In this method the I²C port is active when V_{IN} is above the I²C UVLO (6 V when V_{IN} is rising). IRQ transitions low when V_{IN} goes above I²C UVLO (6 V, V_{IN} rising), and the I²C Read cycle resets IRQ to logic high even if V_{IN} is below UVLO. Even though IRQ is cleared below UVLO, one more Read cycle is required after V_{IN} goes above UVLO, to re-enable the A8305. While V_{IN} is falling, IRQ transitions low when V_{IN} goes below UVLO, and the I²C Read cycle resets IRQ to logic high. A detailed timing diagram is shown in figure 7(B).

When the master device receives an interrupt, it should address all slaves connected to the interrupt line in sequence and read the status register of each to determine which device is requesting attention. As shown in figure 6, the A8305 latches all conditions in the Status register and sets the IRQ to logic low when a UVLO, OCP, or TSD event occurs. The IRQ bit is reset to logic high and the Status register is unlatched when the master acknowledges the status data from the A8305 (an AK bit must be received from the master).

The disable (DIS) and Power Not Good (PNG) conditions do not cause an interrupt and are not latched in the Status register.

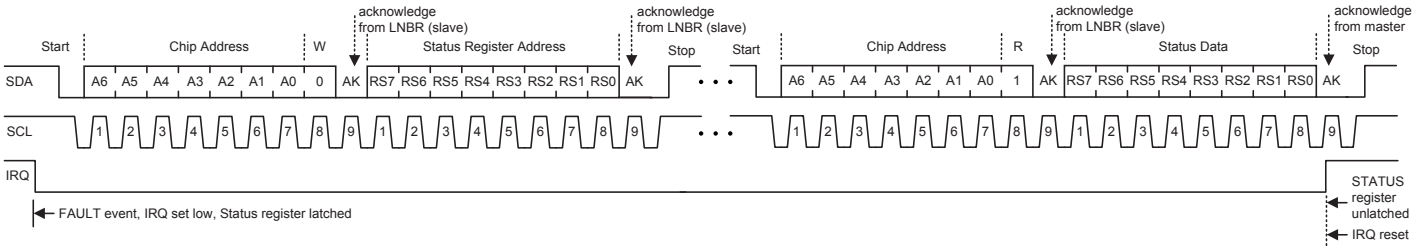
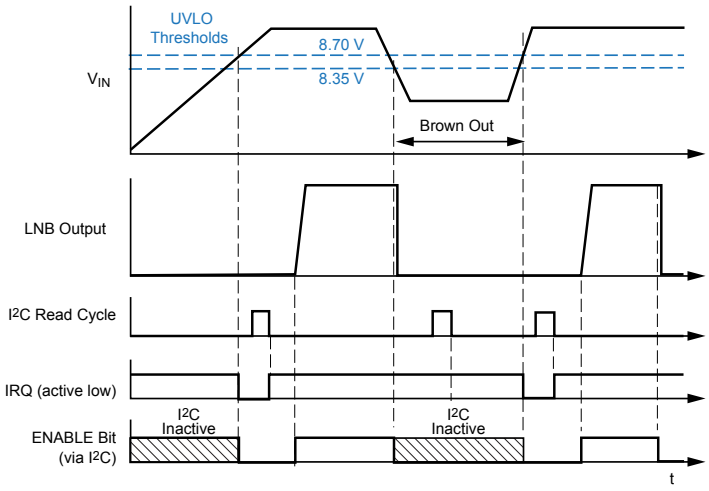
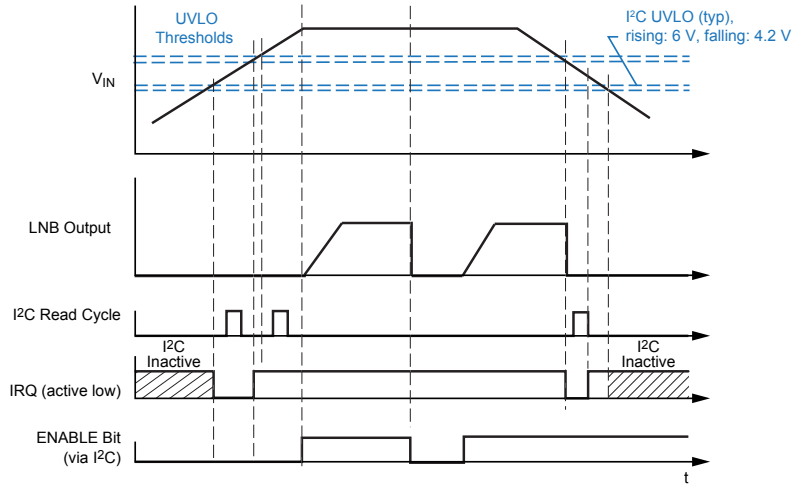


Figure 6. Fault, IRQ, and Status Register Timing. When a UVLO, OCP, or TSD event occurs, the IRQ bit is set low and the Status register is latched. The IRQ bit is reset to high when the A8305 acknowledges it is being read. The Status register is unlatched when the master acknowledges the status data from the A8305.

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com



7(A). IRQ and Fault Clearing in Response to Under Voltage at VIN (UVLO), with I²C address set to (Address 2, Address 3, or Address 4). In this method, while V_{IN} is below 8.70 V (typ), the A8305 is disabled and the I²C port is inactive. After V_{IN} rises above 8.70 V (typ), the I²C port becomes active and the IRQ pin is pulled low. An I²C Read cycle is required, to report and clear the UVLO fault and set the IRQ pin to a logic high, before the A8305 can be enabled. If a brown-out occurs, such that V_{IN} drops below 8.35 V (typ), the A8305 will be disabled and the I²C port will become inactive (note that the IRQ pin will remain high during this time because the A8305 is disabled). After V_{IN} rises above 8.70 V (typ) the I²C port reactivates and the IRQ pin is pulled low to report that a brown-out had occurred. An I²C Read cycle is required to report and clear the UVLO fault before the A8305 can be re-enabled.



7(B). IRQ and Fault Clearing in Response to Under Voltage at VIN (UVLO), with I²C address set to (Address 1). In this method, the I²C port is active when V_{IN} is above I²C UVLO (6 V when V_{IN} is rising). IRQ transitions low when V_{IN} goes above I²C UVLO (6 V, V_{IN} rising), and the I²C Read cycle resets IRQ to logic high even if V_{IN} is below UVLO. Even though IRQ is cleared below UVLO, one more Read cycle is required after V_{IN} goes above UVLO, to re-enable the A8305. While V_{IN} is falling, IRQ transitions low when V_{IN} goes below UVLO, and the I²C Read cycle resets IRQ to logic high.

Figure 7. IRQ and Fault Clearing in Response to Under Voltage at VIN (UVLO), showing the alternate methods, set by selection of I²C address

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

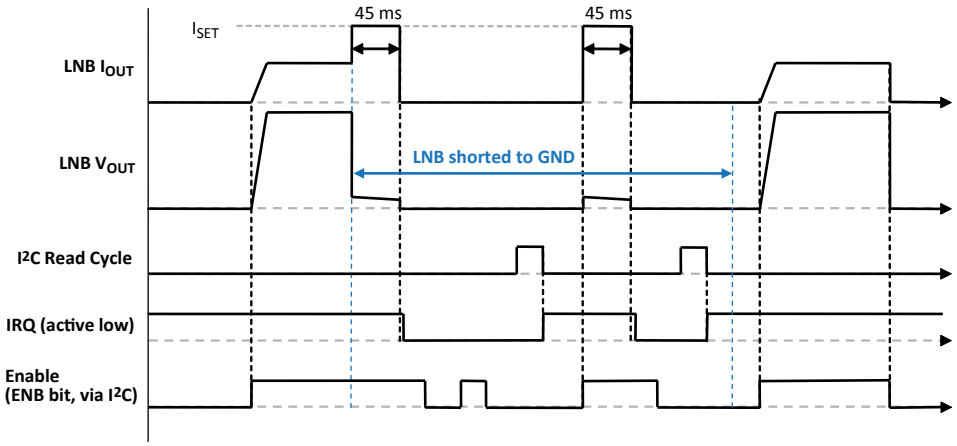


Figure 8. IRQ and Fault Clearing in Response to Overcurrent (OCP). If the LNB output is grounded for more than 45 ms, the LNB output will be shut off, an overcurrent fault (OCP) will be latched in the Status Register, and the IRQ pin will transition low. After an OCP fault, the LNB output does not respond to the Enable (ENB) bit until an I²C Read cycle is executed to report and clear the OCP fault. After a successful I²C Read, the IRQ pin transitions high and the A8305 can be re-enabled, provided the LNB output is no longer grounded.

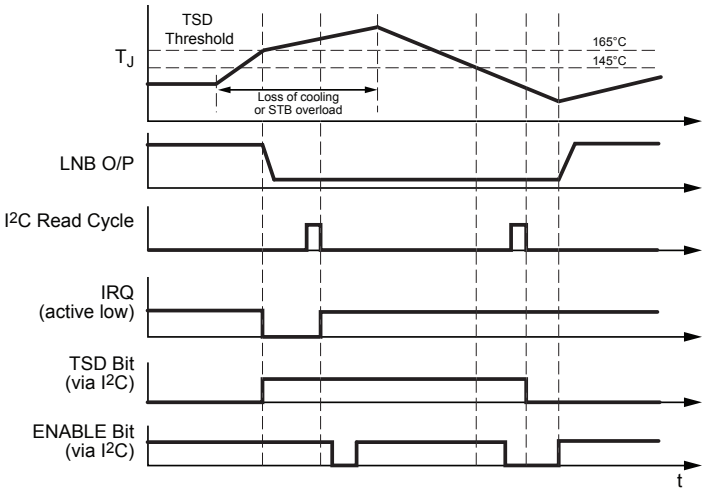
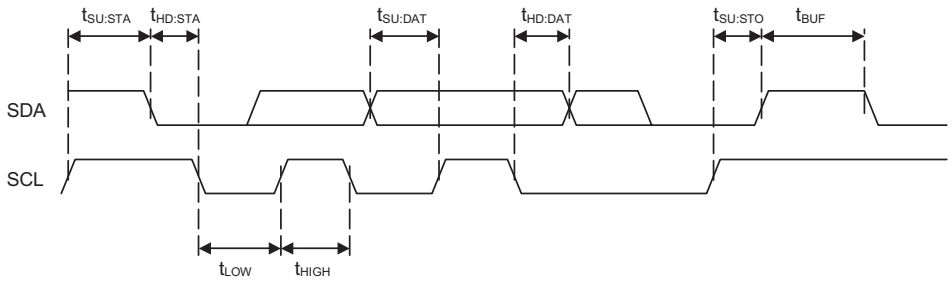


Figure 9. IRQ and Fault Clearing in Response to Thermal Shutdown (TSD). If the LNB junction temperature rises above 165°C (typ), the LNB output will be shut off, a thermal shutdown fault (TSD) will be latched in the Status Register, and the IRQ pin will transition low. After a TSD fault, the LNB output does not respond to the Enable (ENB) bit until an I²C Read cycle is executed to report and clear the TSD fault. After a successful I²C Read, the IRQ pin transitions high and the A8305 can be re-enabled, provided the junction temperature is below 145°C (typ).

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

I²C™-Compatible Interface Timing Diagram



I²C™-Compatible Timing Requirements

Characteristics	Symbol	Min.	Typ.	Max.	Unit
Bus Free Time Between Stop/Start	t_{BUF}	1.3	–	–	µs
Hold Time Start Condition	$t_{HD:STA}$	0.6	–	–	µs
Setup Time for Start Condition	$t_{SU:STA}$	0.6	–	–	µs
SCL Low Time	t_{LOW}	1.3	–	–	µs
SCL High Time	t_{HIGH}	0.6	–	–	µs
Data Setup Time	$t_{SU:DAT}$	100	–	–	ns
Data Hold Time*	$t_{HD:DAT}$	0	–	900	ns
Setup Time for Stop Condition	$t_{SU:STO}$	0.6	–	–	µs
Output Fall Time ($V_{fI2COut(H)}$ to $V_{fI2COut(L)}$)	$t_{fI2COut}$	–	–	250	ns

*For $t_{HD:DAT}$(min), the master device must provide a hold time of at least 300 ns for the SDA signal in order to bridge the undefined region of the SCL signal falling edge.

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

Control Registers (I²C™-Compatible Write Register)

All main functions of the A8305 are controlled through the I²C™ compatible interface via the 8-bit Control register. Table 2 shows the functionality and bit definitions of the Control register. At power-up, the Control register is initialized to all 0s.

Table 2. Control Register Definition

Bit	Name	Function	Description
0	VSEL0	LNB output voltage control See Table 3 for available output voltage selections	The available voltages provide levels for all the common standards plus the ability to add line compensation. VSEL0 is the LSB and VSEL2 is the MSB to the internal DAC.
1	VSEL1		
2	VSEL2		
3	ENB	0: Disable LNB Output 1: Enable LNB Output	Turns the LNB output on or off.
4	–	Set to 0	Unused
5	–		
6	–		
7	–		

Table 3. Output Voltage Selection

VSEL2	VSEL1	VSEL0	LNB (V)
0	0	0	13.333
0	0	1	13.667
0	1	0	14.333
0	1	1	15.667
1	0	0	18.667
1	0	1	19.000
1	1	0	19.667
1	1	1	20.000

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

Status Registers (I²C™-Compatible Read Register)

The main fault conditions, undervoltage lockout (UVLO), overcurrent (OCP), and thermal shutdown (TSD), are all indicated by setting the relevant bits in the Status register. In all fault cases, after the bit is set, it remains latched until the I²C™ master has successfully read the A8305, assuming the fault has been resolved.

The undervoltage lockout (UVLO) bit indicates either the input voltage at the VIN pin is too low or the A8305 internal supply voltage (V_{REG}) is too low.

The Disable bit (DIS) indicates the status of the LNB output. The DIS bitis set when either a fault occurs (UVLO, OCP, TSD, or CPOK) or when the LNB output is turned off using the Enable bit (ENB) via the I²C™ interface. The DIS bit is latched and is only reset when there are no faults and the A8305 output is turned on again using the Enable (ENB) bit via the I²C™ interface. The Power Not Good (PNG) and Charge Pump OK (CPOK) bits are set based on the conditions sensed at the LNB output and VCP pins, respectively. These bits are not latched and, unlike the other fault bits, may become reset without an I²C™ read sequence. The PNG and CPOK bits are continuously updated.

There are three methods to detect when the Status register changes: responding to the interrupt request (IRQ) pin going low, continuously polling the Status register via the I²C™ interface, or detecting a fault condition external to the A8305 and performing a diagnostic poll of the A8305. In any case, the master should read and re-read the Status register until the status changes.

Table 4. Status Register Description and IRQ Operation

Bit	Name	Function	Latched?	Reset Condition	Effect on IRQ Pin
0	DIS	LNB output disabled	Yes	LNB enabled and no faults	None
1	CPOK	Charge pump OK	No	$V_{CP} > V_{BOOST} + 5V$	None
2	OCP	Overcurrent	Yes	I²C™ READ and $I_{LOAD} < I_{SET}$	IRQ set low
3	TRIMS	Trim bits locked	Yes	None	None
4	PNG	Power Not Good	No	LNB voltage within range	None
5	–	Not used	–	–	–
6	TSD	Thermal shutdown	Yes	I²C™ READ and $T_J < 145°C$	IRQ set low
7	UVLO	VIN or VREG undervoltage	Yes	I²C™ READ and $V_{IN} > 9.0$ V	IRQ set low

Table 5. Status Register Bit Descriptions

Bit	Name	Description
0	DIS	The DIS bit is set to 1 when the A8305 is disabled, (ENB = 0) or there is a fault: UVLO, OCP, CPOK, or TSD.
1	CPOK	If this bit is set low, the internal charge pump is not operating correctly (VCP). If the charge pump voltage is too low, the LNB output is disabled and the DIS bit is set.
2	OCP	This bit will be set to a 1 if the LNB output current exceeds the overcurrent threshold ($I_{OUT(MAX)}$) for more than the overcurrent disable time (t_{DIS}). If the OCP bit is set to 1, then the DIS bit is also set to 1.
3	TRIMS	Factory use only.
4	PNG	Set to 1 when the A8305 is enabled and the LNB output voltage is either too low or too high (nominally ±9% from the LNB DAC setting). Set to 0 when the A8305 is enabled and the LNB voltage is within the acceptable range (nominally ±5% from the LNB DAC setting).
5	–	Not used
6	TSD	The TSD bit is set to 1 if the A8305 has detected an overtemperature condition. If the TSD bit is set to 1, then the DIS bit is also set to 1.
7	UVLO	The UVLO bit is set to 1 if either the voltage at the VIN pin or the voltage at the VREG pin is too low. If the UVLO bit is set to 1, then the DIS bit is also set to 1.

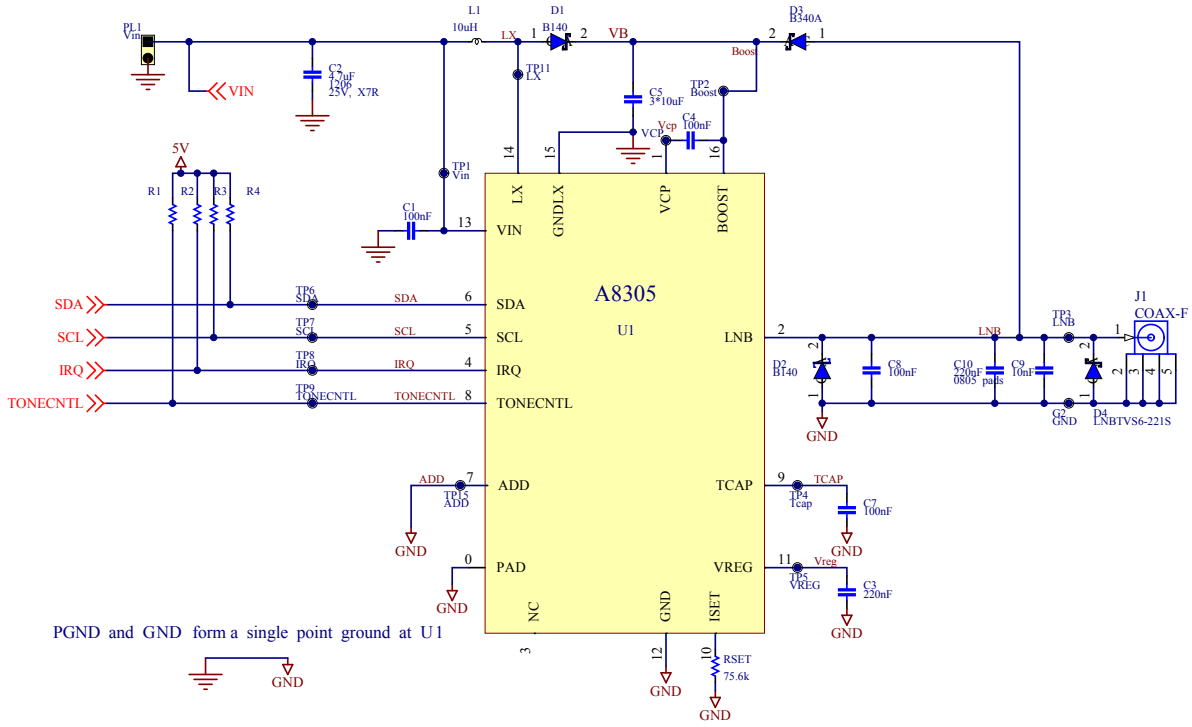
Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

APPLICATION INFORMATION

Table 6. Component Selection Table for Functional Block Diagram

Component	Characteristics	Manufacturer Device
C1, C4, C7, C8	100 nF, 50 V, X5R or X7R, 0603	
C2	2X 4.7 µF, or 1X 10 µF, 25 V, X5R or X7R, 1206	
C3	220 nF, 10 V_{MIN}, X5R or X7R, 0402 or 0603	
C5	4X 4.7 µF, ±10%, 50 V, X7R, 1210	Murata: GRM32ER71H475KA88 Taiyo Yudan: UMK325B7475KM AVX: 12105C475KAT2A
	3X 10 µF, ±10%, 35 V, X7R, 1210	Murata: GCM32ER71E106K
C9	10 nF, 50 V, X5R or X7R, 0402 or 0603	
C10	220 nF, 50 V, X5R or X7R, 0805	
D1, D2	Schottky diode, 40 V, 1 A, SOD-123	Diodes, Inc: B140HW-7 Central Semi: CMMSH1-40
D3	Schottky diode, 40 V, 3 A, SMA	Sanken: SFPB-74 Vishay: B340A-E3/5AT Diodes, Inc.: B340A-13-F Central Semi: CMSH3-40MA
D4	TVS, 20 V_{RM}, 32 V_{CL} at 500 A (8/20 µs), 3000 W	ST: LNBTVS6-221S, Littelfuse: 3.0SMCJ20A
L1	15 µH	Cooper Bussman DR1030-150-R
R1 to R4	Determined by V_{DD}, bus capacitance, etc.	

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com



See table 7 for bill of materials

Schematic 1. A8305 application circuit for LNB output currents < 350 mA.

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

Table 7. Component Selection Table for Application Circuit Schematic 1

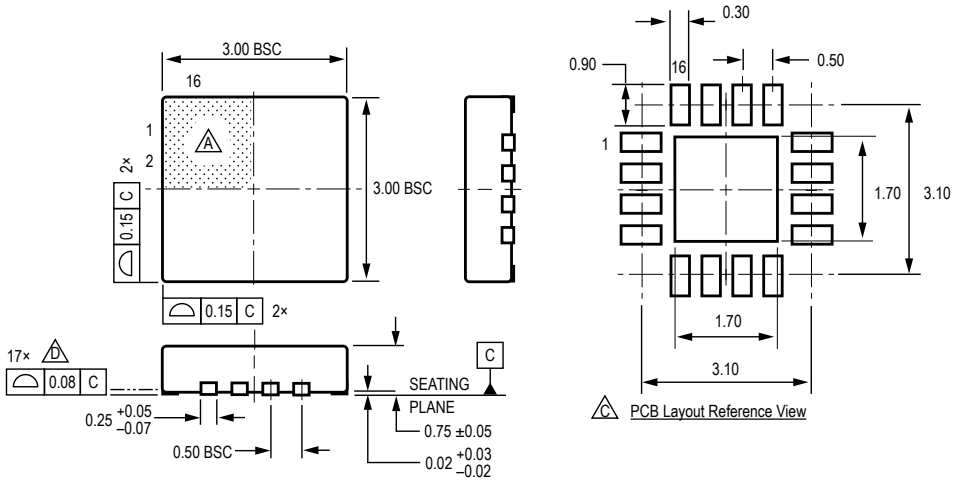
Component	Characteristics	Manufacturer Device
C1, C4, C7, C8	100 nF, 50 V, X5R or X7R, 0603	
C2	4.7 µF, 25 V, 10%, X7R	
C3	220 nF, 10 V_{MIN}, X5R or X7R, 0402 or 0603	
C5	4X 4.7 µF, ±10%, 50 V, X7R, 1210	Murata: GRM32ER71H475KA88 Taiyo Yudan: UMK325B7475KM AVX: 12105C475KAT2A
	3X 10 µF, ±10%, 35 V, X7R, 1210	Murata: GCM32ER71E106K
C9	10 nF, 50 V, X5R or X7R, 0402 or 0603	
C10	220 nF, 50 V, X5R or X7R, 0805	
D1, D2	Schottky diode, 40 V, 1 A, SOD-123	Diodes, Inc: B140HW-7 Central Semi: CMMSH1-40
D3	Schottky diode, 40 V, 3 A, SMA	Sanken: SFPB-74 Vishay: B340A-E3/5AT Diodes, Inc.: B340A-13-F Central Semi: CMSH3-40MA
D4	TVS, 20 V_{RM}, 32 V_{CL} at 500 A (8/20 µs), 3000 W	ST: LNBTVS6-221S, Littelfuse: 3.0SMCJ20A
L1	10 µH	Taiyo Yuden: NRS8040T100MJGJ
R1 to R4	Determined by V_{DD}, bus capacitance, etc.	

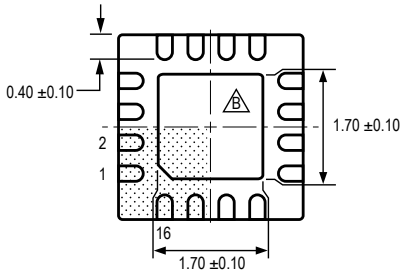
Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

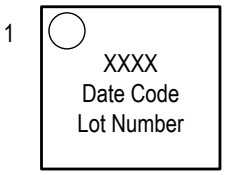
Package ES 16-Pin QFN

For Reference Only – Not for Tooling Use

(Reference Allegro DWG-0000222 Rev. 4 or JEDEC MO-220WEED)
Dimensions in millimeters
Exact case and lead configuration at supplier discretion within limits shown







E Standard Branding Reference View

A Terminal #1 mark area.

B Exposed thermal pad (reference only, terminal #1 identifier appearance at supplier discretion).

C Reference land pattern layout (reference IPC7351 QFN50P300X300X80-17W4M);
All pads a minimum of 0.20 mm from all adjacent pads; adjust as necessary to meet application process requirements and PCB layout tolerances; when mounting on a multilayer PCB, thermal vias at the exposed thermal pad land can improve thermal dissipation (reference EIA/JEDEC Standard JESD51-5).

D Coplanarity includes exposed thermal pad and terminals.

E Branding scale and appearance at supplier discretion.

Lines 1, 2, 3 = 4 characters

Line 1: Part Number
Line 2: 4 digit Date Code
Line 3: Characters 5, 6, 7, 8 of Assembly Lot Number

Pin 1 Dot top left
Center align

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com

Revision History

Number	Date	Description
4	July 9, 2018	Minor editorial updates
5	February 8, 2019	Product status changed to Pre-End-of-Life
6	July 1, 2019	Product status changed to Last Time Buy
7	September 19, 2019	Product status changed to active
8	September 15, 2021	Updated package drawing (page 22)
9	July 1, 2024	Updated product status to Discontinued

Allegro MicroSystems
955 Perimeter Road
Manchester, NH 03103-3353 U.S.A.
www.allegromicro.com